


<b>Search Notes</b> 	<b>Application/Control No.</b> 10700017	<b>Applicant(s)/Patent Under Reexamination</b> MCVOY ET AL.
	<b>Examiner</b> Chen, Qing	<b>Art Unit</b> 2191

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Updated EAST Search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) -- See Search History Printout	11/20/2007	QC
717/110-113,122,169,170,175; 707/203 (limited class search)	11/20/2007	QC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner